

MEASUREMENT UNCERTAINTY AND METROLOGICAL CONFIRMATION IN DOCUMENTED QUALITY SYSTEMS

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Abstract – *The effect of measurement uncertainty on estimates and decisions performed under a regime of quality control and improvement, is considered in this paper. Standard statistical quality tools are analyzed such as control charts and instrument calibration procedures. Their performance is characterized under the assumption of both Gaussian and uniformly distributed measurement uncertainty. Exact and approximate expressions are derived that allow the design of suitable procedures including the contribution of measurement uncertainty.*

Keywords – Test uncertainty ratio, metrological confirmation, statistical quality control, calibration.

1. INTRODUCTION

The extensive application of management models aimed at the assurance and improvement of company process quality levels has produced stimulating debates on the role of test and measurement in the development of a documented quality system. A prominent position has been taken by the widely accepted models described in the ISO 9000 series of standards, which have been applied worldwide with steadily growing rates. In fact, in ISO 9001:1994 paragraph 4.11 it is stated that: “The supplier shall identify, calibrate, and adjust all inspection, measuring and test equipment . . .” Even in the recently published revision of such standards, in many other guidance norms and in topic-specific standards [1], [2] the importance of test and measurement activities has always been highlighted. Moreover, the recognition by the international agencies, of the impelling need to regulate such a complicated matter has led to the publication of an European Prestandard [3], known as the “Guide to the Expression of Uncertainty in Measurement,” and of an important norm regarding the accreditation of laboratories [4], which now supersedes the former ISO/IEC Guide 25:1990.

According to the cited documents and to the best practices in managing instrumentation and product quality in a mature industrial environment, several tasks are commonly carried out, that require caution in dealing with uncertainty and related probabilistic risk assessment. This paper addresses the issues arising in a quality-oriented organization, from the use of measuring equipment involved in decision-making processes. At first, a brief description is made of the industrial practices requiring strict-sense measurements. Then, potential consequences of uncontrolled sources of uncertainty are analyzed both qualitatively and quantitatively.

2. MEASUREMENTS AND QUALITY CONTROL

Running a program of statistical quality control and managing measurement apparatus in accordance to the requirements of *metrological confirmation* [1], affects the procedures regarding process surveillance through

- control charts;
- conformance testing;
- calibration.

Many of the above cited techniques require prior evaluation of the principal statistical properties of the random variable \mathbf{x} modeling the process outcome. Since uncertainty will affect the measured data, the manufacturing process behavior can be determined only up to a disturbing contribution related to the measurement procedure. If the random variable ϵ represents the measurement uncertainty, then $\mathbf{y} \triangleq \mathbf{x} + \epsilon$ is the random variable describing the measurement process outcome. Consequently, if ϵ is zero-mean, under the common assumption of statistical independence, $\mu_y = \mu_x$ and $\sigma_y^2 = \sigma_x^2 + \sigma_\epsilon^2$, where μ and σ^2 represent the mean value and variance of the corresponding random variables, respectively. The sampling mean $\hat{\mu}_y \triangleq 1/N \sum_{n=0}^{N-1} \mathbf{y}[n]$, is commonly employed to estimate μ_y , where N is the number of processed samples and $\mathbf{y}[\cdot]$ is the sequence of measurement process outcomes. Similarly, the standard deviation of \mathbf{y} is usually estimated using

$$\hat{\sigma}_y \triangleq \sqrt{\frac{1}{N-1} \sum_{n=0}^{N-1} (\mathbf{y}[n] - \hat{\mu}_y)^2}. \quad (1)$$

While the sampling mean is an unbiased estimator of the process mean, it is known that, when \mathbf{y} is Gaussian, $(\hat{\sigma}_y/\sigma_y)\sqrt{N-1}$ is distributed as the square-root of a χ^2 random variable with $N-1$ degrees of freedom. Thus, it can be proved that [5]:

$$E\{\hat{\sigma}_y\} = \sigma_y c_4(N), \quad c_4(N) \triangleq \sqrt{\frac{2}{N-1}} \frac{\Gamma(N/2)}{\Gamma[(N-1)/2]}, \quad (2)$$

where $E\{\cdot\}$ is the expectation operator and $\Gamma(\cdot)$ is the so-called gamma function [6].

In the following subsections, it is shown how to include the effects of measurement uncertainty in quality-oriented practices aimed at process surveillance.

2.1 Control Charts and Measurement Uncertainty

Control charts are usually employed to monitor the average behavior and the variability of quality characteristics in a

manufacturing or service process [5]. A widely applied pair of control charts is the \bar{x} - σ pair, which are used to control the behavior of sampled mean and sampled standard deviation of \mathbf{x} . Both control chart limits, that is the boundaries that if trespassed will trigger an *out-of-control* event, are frequently set by estimating the mean value and standard deviation of the random variable \mathbf{x} .

In fact, in a chart designed to monitor the process average (\bar{x} -chart), it is common to set the control limits around a given process mean value, μ_0 at a distance of $\pm 3\sigma_x$ ¹. This choice sets also the probability of Type I errors. However, since σ_x is known only through (1), the contribution of ϵ will affect the chart property with respect to probability of Type II errors and out-of-control *average run length* (ARL₁). The former quantity represents the probability of concluding that the process average is in control while it is out-of-control, while ARL₁ defines the average number of tests to be carried out before an out-of-control status is detected. Clearly, both the probability of Type II errors and ARL₁ are required to be low, so to improve the effectiveness of the control chart.

In order to appreciate the magnitude of the deviation from nominal behavior resulting from the effect of measurement uncertainty, assume the random variables to be Gaussian. Then, the probability of Type II errors, $\beta_{\bar{x}}(\cdot)$, that is the operating-characteristic curve, is given by:

$$\beta_{\bar{x}}(R) \triangleq \Pr\{\text{Type II err.}\} = \Pr\{\text{LCL} < \mathbf{y} \leq \text{UCL} | \mu_x \neq \mu_0\} \\ \simeq \Phi\left(3 - \frac{\delta}{\sigma_x \sqrt{1 + \frac{1}{R^2}}}\right) - \Phi\left(-3 - \frac{\delta}{\sigma_x \sqrt{1 + \frac{1}{R^2}}}\right) \quad (3)$$

where LCL and UCL are the chart lower and upper control limits and $\Phi(\cdot)$ is the distribution function of a zero-mean unity-variance Gaussian random variable. Moreover, in (3), $\delta \triangleq \mu_x - \mu_0$, that is the deviation from the mean value that justifies the out-of-control status, and $R \triangleq \frac{\sigma_x}{\sigma_\epsilon}$ represents the

¹ A single observation is assumed in this paragraph. In the case of N independent observations, results still hold provided σ_x is replaced by σ_x/\sqrt{N} .

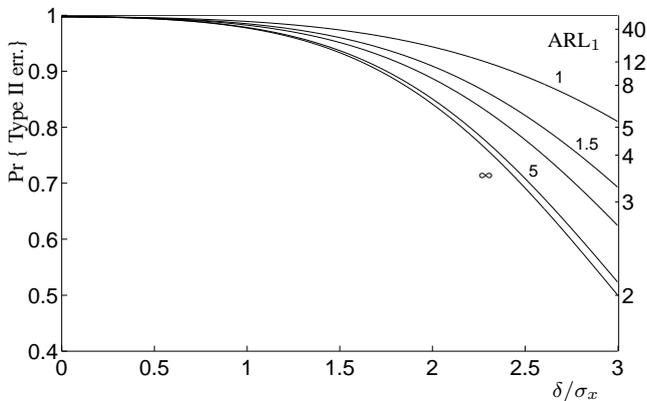


Figure 1. Probability of Type II errors and ARL₁ when running an \bar{x} -control chart under the assumption of a Gaussian-distributed quality characteristics as a function of normalized deviation from the mean under the effects of measurement uncertainty.

test uncertainty ratio (TUR). Expression (3) holds approximately, since LCL and UCL are usually estimated in a prior chart design phase using the sampling mean and (1) applied to a large number of samples.

With the aim of determining how measurement uncertainty affects the probability of Type II errors, (3) has been plotted in Fig. 1 as a function of δ/σ_x assuming $R \in \{1, 1.5, 2, 5, \infty\}$, along with the corresponding values of $\text{ARL}_1(R) = 1/[1 - \beta_{\bar{x}}(R)]$ reported on the right axis. The symbol ‘ ∞ ’ applies when $\sigma_\epsilon = 0$, that is when measurement uncertainty can be neglected. The graph in Fig. 1 shows that for given δ and σ_x , by decreasing R , the effect of a given deviation is increasingly obscured by the presence of measurement uncertainty. In order to highlight the role of TUR in determining the behavior of (3) as a function of $\delta/\sigma_x < 0.5$, $\beta_{\bar{x}}(\cdot)$ has been expanded asymptotically assuming $R \rightarrow \infty$. Accordingly, the following results

$$\beta_{\bar{x}}(R) \simeq \beta_{\bar{x}}(\infty) + \frac{\delta}{2\sigma_x R^2} \left[\phi\left(3 - \frac{\delta}{\sigma_x}\right) - \phi\left(-3 - \frac{\delta}{\sigma_x}\right) \right], \\ R \rightarrow \infty \quad (4)$$

in which $\phi(\cdot)$ is the probability density function of a zero-mean unity-variance Gaussian random variable and $\beta_{\bar{x}}(\infty) \triangleq \lim_{R \rightarrow \infty} \beta_{\bar{x}}(R)$, that is the probability of Type II errors when measurement uncertainty can be neglected. Simulation results show that the absolute difference between (4) and (3) is bounded by $6 \cdot 10^{-3}$ as long as $R > 3$ and $\delta/\sigma_x < 0.5$. Thus, under these assumptions, the deviation $\beta_{\bar{x}}(\infty) - \beta(R)$ vanishes approximately as $1/R^2$. Moreover, numerical simulations show that, for a given value of $R > 1$, (3) well approximates the probability of Type II errors also when uniformly distributed uncertainty is assumed.

A σ control-chart is designed in order to monitor the equivalence of the measured process standard deviation to a preset value σ_0 , representing the standard deviation of the process when in statistical control, and usually determined in a prior phase of the chart design. Because of measurement uncertainty, such prior evaluation provides $\sigma_{y0} = \sigma_0 \sqrt{1 + 1/R^2}$.

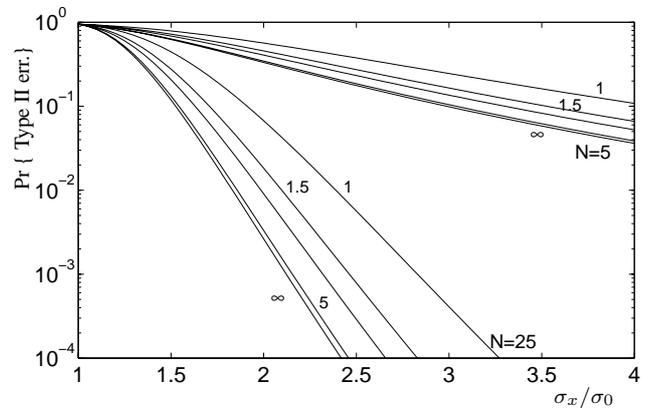


Figure 2. Probability of Type II errors when running a σ -control chart assuming Gaussian-distributed quality characteristics as a function of the ratio between out-of-control and in-control process standard deviations and under the effects of measurement uncertainty.

Thus, since (1) is employed to evaluate estimate to be positioned on the chart, the resulting control chart will exhibit a central line equal to $\sigma_{y_0}c_4(N)$. Moreover, by assuming $LCL=0$, for a given value α of the probability of Type I errors, $UCL=\sigma_y\chi_{N-1,1-\alpha}/\sqrt{N-1}$ results, where $\chi_{N-1,1-\alpha}$, is the $(1-\alpha)$ -quantile of the square-root of a chi-square random variable with $N-1$ degrees-of-freedom [5]. Consequently, the probability of Type II errors is given by (App. A):

$$\beta_\sigma(R) \triangleq X_{N-1}^2 \left(\frac{1 + \frac{1}{R^2}}{\lambda^2 + \frac{1}{R^2}} \chi_{N-1,1-\alpha}^2 \right) \quad (5)$$

where $X_{N-1}^2(\cdot)$ and $\chi_{N-1,1-\alpha}^2$ represent the probability distribution function and the $(1-\alpha)$ -quantile of a chi-square random variable with $N-1$ degrees-of-freedom, respectively.

Moreover, in (5), $\lambda \triangleq \sigma_x/\sigma_0$ where $\sigma_x \neq \sigma_0$, is the process standard deviation justifying the out-of-control condition. Observe that, when $R \rightarrow \infty$ and $\lambda \rightarrow 1$, (5) is equal to $1-\alpha$, as expected. In Fig. 2, $\beta_\sigma(\cdot)$ has been plotted assuming $N=5$ and 25 for various values of the TUR. The curve labeled with $R=\infty$ corresponds to the absence of measurement uncertainty.

By following the same reasoning leading to (4) we obtain:

$$\beta_\sigma(R) \simeq \beta_\sigma(\infty) + \frac{\lambda^2 - 1}{R^2 \lambda^4} \chi_{N-1,1-\alpha}^2 x_{N-1}^2 \left(\frac{\chi_{N-1,1-\alpha}^2}{\lambda^2} \right) \quad R \rightarrow \infty \quad (6)$$

where $\beta_\sigma(\infty) \triangleq \lim_{R \rightarrow \infty} \beta_\sigma(R)$, and $x_{N-1}^2(\cdot)$ represents the probability density function of a chi-square random variable with $N-1$ degrees-of-freedom. Numerical investigations show that the absolute error between (5) and (6) is bounded by 10^{-2} as long as $R > 3$, $5 \cdot 10^{-3} < \alpha < 5 \cdot 10^{-2}$ and $5 \leq n \leq 100$. Moreover, as evidenced by (6), the deviation from $\beta_\sigma(\infty)$ vanishes as $1/R^2$.

2.2 Conformance Testing and Measurement Uncertainty

Conformance testing is the procedure by which a quality characteristic is measured against pre-set limits. These specifications may be a customer requirement or a legal obligation or part of the production regime. A common situation occurs when the product fails the test if the measured quantity is found to be external from a given interval. The contribution of measurement uncertainty may alter the final decision. In fact, because of the measurement procedure, an out-of-limit product may be wrongly accepted or a valid product may be wrongly rejected. Both situations can be characterized through corresponding probabilities of occurrence which define the so-called *consumer-risk* (CR) and *producer-risk* (PR) respectively defined as,

$$CR \triangleq \Pr\{\mathbf{x} \notin \mathcal{A} | \mathbf{y} \in \mathcal{A}\} \quad (7)$$

and

$$PR \triangleq \Pr\{\mathbf{x} \in \mathcal{A} | \mathbf{y} \notin \mathcal{A}\} \quad (8)$$

with $\mathcal{A} \triangleq (\mu_x - S, \mu_x + S)$, where S is the test specification limit. Under the assumption of \mathbf{x} being Gaussian-distributed,

CR and PR depend on whether the uncertainty is Gaussian or uniformly distributed. By assuming uniformly-distributed uncertainty the following results:

$$CR = \begin{cases} \operatorname{erf}\left(\frac{1}{R}\sqrt{\frac{3}{2}} - \frac{\bar{S}}{\sqrt{2}}\right) \left(\frac{\bar{S}R}{2\sqrt{3}} - \frac{1}{2}\right) \\ + \operatorname{erf}\left(\frac{1}{R}\sqrt{\frac{3}{2}} + \frac{\bar{S}}{\sqrt{2}}\right) \left(\frac{\bar{S}R}{2\sqrt{3}} + \frac{1}{2}\right) - \frac{R\bar{S}}{\sqrt{3}} \operatorname{erf}\left(\frac{\bar{S}}{\sqrt{2}}\right) \\ - 2\frac{R}{\sqrt{6\pi}} e^{-\frac{1}{2}\left(\frac{3}{R^2} + \bar{S}^2\right)} \sinh\left(\frac{\bar{S}\sqrt{3}}{R}\right) & \bar{S} \leq \frac{\sqrt{3}}{2R} \\ \left(\frac{\bar{S}R}{2\sqrt{3}} + \frac{1}{2}\right) \left[\operatorname{erf}\left(\frac{1}{R}\sqrt{\frac{3}{2}} + \frac{\bar{S}}{\sqrt{2}}\right) - \operatorname{erf}\left(\frac{\bar{S}}{\sqrt{2}}\right) \right] \\ + \frac{R}{\sqrt{6\pi}} e^{-\frac{\bar{S}^2}{2}} \left[e^{-\left(\frac{\bar{S}\sqrt{3}}{R} + \frac{3}{2R^2}\right)} - 1 \right] & \bar{S} > \frac{\sqrt{3}}{2R} \end{cases} \quad (9)$$

$$PR = \begin{cases} -\frac{1}{\sqrt{3}} \operatorname{erf}\left(\frac{\bar{S}}{\sqrt{2}}\right) (R\bar{S} - \sqrt{3}) & \bar{S} \leq \frac{\sqrt{3}}{2R} \\ \left[\operatorname{erf}\left(\frac{\bar{S}}{\sqrt{2}}\right) + \operatorname{erf}\left(\frac{1}{R}\sqrt{\frac{3}{2}} - \frac{\bar{S}}{\sqrt{2}}\right) \right] \left(\frac{1}{2} - \frac{\bar{S}R}{2\sqrt{3}}\right) \\ + \frac{R}{\sqrt{6\pi}} e^{-\frac{\bar{S}^2}{2}} \left[e^{\left(\frac{\bar{S}\sqrt{3}}{R} - \frac{3}{2R^2}\right)} - 1 \right] & \bar{S} > \frac{\sqrt{3}}{2R} \end{cases} \quad (10)$$

Conversely, by assuming Gaussian-distributed uncertainty, CR and PR are in the form of double integrals, which can not be integrated analytically. Then, using numerical approximations, and assuming $1 \leq R \leq 4$, and $1 \leq \bar{S} \leq 10$, with $\bar{S} \triangleq S/\sigma_x$, the following applies (App. B):

$$CR \simeq \frac{5}{\sqrt{2K_0}} \operatorname{erf}\left(\sqrt{2} \cdot R\bar{S}\right) \left[1 - \operatorname{erf}\left(\frac{100\bar{S} + 385R}{20\sqrt{K_0}}\right) \right] \cdot e^{-\frac{1}{2}\bar{S}^2 + \frac{1}{2K_0}(77R\bar{S} + 50\bar{S}^2 + 30R^2)} \quad (11)$$

where $K_0 \triangleq 38R^2 - 3R + 55$, and $\operatorname{erf}(\cdot)$ is the error function [6]. Moreover,

$$PR \simeq 5\sqrt{\frac{5}{2K_1}} e^{-\frac{R(756R\bar{S}^2 + 1100\bar{S}\sqrt{2} - 605R)}{8K_1}} \cdot \left\{ \operatorname{erf}\left[\frac{100\bar{S} + 151R^2\bar{S} + 55\sqrt{2}R}{10\sqrt{K_1}}\right] - \operatorname{erf}\left[\frac{11\sqrt{2}R - 20\bar{S}}{2\sqrt{K_1}}\right] \right\} \quad (12)$$

where $K_1 \triangleq 250 + 189R^2$. Simulation results show that (11) and (12) are accurate to within 4% to the corresponding probabilities evaluated without using approximations. By integrating the expressions arising from (7) and (8) or by using (9) – (12) directly, the conformance test parameter can be set, by also taking into account the effect of measurement uncertainty.

In order to illustrate the behavior of CR and PR, (9) through (12) have been graphed in Fig. 3 as a function of the TUR, assuming various values for the normalized threshold levels. Notice that, for a given value of TUR, the CR is larger when uniformly distributed uncertainty is considered. Thus, from this point of view, instruments exhibiting Gaussian behavior are to be preferred. Accordingly, refer to [8] and [9] for a description of experimental results reporting about commercially available instruments characterized by Gaussian and/or uniformly

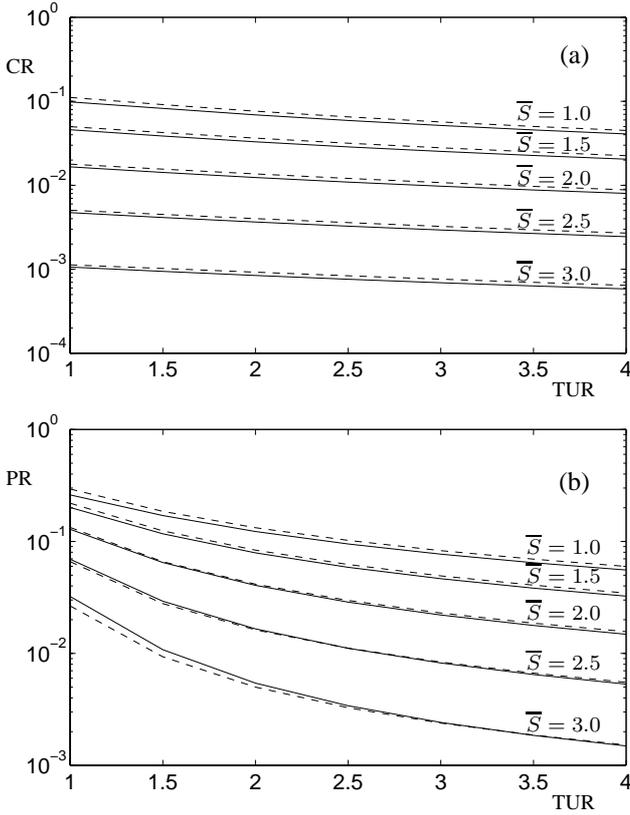


Figure 3. Consumer (a) and producer (b) risks as a function of TUR and \bar{S} , assuming Gaussian– (solid) and uniformly–distributed (dashed) uncertainties.

distributed uncertainty. Finally consider that *guardbanding*–based techniques may be adopted for dealing with risks induced by measurement uncertainty. For a discussion about these methods refer to [10] and [11].

2.3 Calibration and Equipment Uncertainty

The need of verifying if an instrument obeys the requirements of metrological confirmation demands that the instrument be periodically tested and eventually calibrated. Accordingly, a suitable source of known accuracy is employed as the stimulus signal, so that the tested instrument uncertainty can be estimated. If such uncertainty remains inside an interval assuring the instrument working status, no calibration is performed. On the contrary, calibration may be required if, for some particular input values, the instrument uncertainty is larger than acceptable. Again, the intrinsic uncertainty of the stimulus source, can be at the origin of the two events leading to the consumer and producer risks. Moreover, by defining the test uncertainty ratio as the ratio between variances characterizing the instrument uncertainty and the source intrinsic uncertainty, (9)–(12) still hold true.

Once the evaluation of such probabilities can be mastered, the verification of instrument conformance can be achieved by following one of the many suggestions provided in the literature on how to choose specification limits [10], [11]. Particular caution must be exercised in this case when dealing with both the consumer and producer risks. While passing a non-

conforming instrument may lead to even potentially harmful consequences, being excessively conservative may put too many costs on the producer’s side. In fact, besides economic considerations, unnecessary calibrations might induce ‘peaking and tweaking’ effects in analog instruments [12] and/or might alter the managing habits in dealing with recalibration procedures. The suggested technique of widening/shortening the recalibration interval according to the instrument previous conformance status, in accordance with the *simple response method* described in [2], is certainly affected by unwise choices regarding the consumer and producer risks.

CONCLUSION

In this paper, the effects of measurement uncertainties on quality oriented measurements, are taken into considerations. Directions are given on how to choose the accuracy of measurement apparatus in order to reduce their effects when dealing with control charts, with conformance testing and with calibration of equipment carried out under programs of metrological confirmation in documented quality systems. Producer and consumer risks are recalled and new approximate expressions are presented under the common assumptions of Gaussian distributed uncertainties. The analysis has proved that the risks associated with the added measurement uncertainty are in all cases regulated by the test uncertainty ratio.

APPENDIX A

DERIVATION OF EXPRESSION (5)

The probability of Type II errors, $\beta_\sigma(\cdot)$ is given by:

$$\begin{aligned} \beta_\sigma(R) &\triangleq \Pr \{ \hat{\sigma}_y < UCL | \sigma_x \neq \sigma_0 \} \\ &= \Pr \left\{ \hat{\sigma}_y < \chi_{N-1, 1-\alpha} \frac{\sigma_{y0}}{\sqrt{N-1}} | \sigma_x \neq \sigma_0 \right\} \end{aligned} \quad (\text{A.1})$$

Thus,

$$\beta_\sigma(R) = \Pr \left\{ \frac{\hat{\sigma}_y}{\sigma_y} \sqrt{N-1} < \chi_{N-1, 1-\alpha} \frac{\sigma_{y0}}{\sigma_y} | \sigma_x \neq \sigma_0 \right\}. \quad (\text{A.2})$$

Since, in (A.2), the leftmost term in the brackets is distributed as the square–root of a chi–square random variable with $N-1$ degrees–of–freedom, we obtain (5), once observed that

$$\frac{\sigma_{y0}}{\sigma_y} = \sqrt{\frac{1 + \frac{1}{R^2}}{\lambda^2 + \frac{1}{R^2}}}. \quad (\text{A.3})$$

APPENDIX B

APPROXIMATIONS FOR CONSUMER’S AND PRODUCER’S RISKS

The consumer risk can be expressed as:

$$\begin{aligned} \text{CR} &\triangleq \int_{\mu_x - S}^{\mu_x + S} \int_{-\infty}^{\mu_x - S} f_{xy}(x, y) dx dy \\ &\quad + \int_{\mu_x - S}^{\mu_x + S} \int_{\mu_x + S}^{\infty} f_{xy}(x, y) dx dy \end{aligned} \quad (\text{B.1})$$

where $f_{xy}(\cdot, \cdot)$ is the joint probability density function of \mathbf{x} and \mathbf{y} . By assuming independent zero-mean Gaussian random variables, from (B.1) we obtain

$$\text{CR} = \frac{1}{2\pi} \int_{\bar{S}}^{\infty} e^{-\frac{t^2}{2}} \gamma(R, \bar{S}, t) dt \quad (\text{B.2})$$

where $\gamma(R, \bar{S}, t) \triangleq \left\{ \text{erf} \left(R \frac{t+\bar{S}}{\sqrt{2}} \right) - \text{erf} \left(R \frac{t-\bar{S}}{\sqrt{2}} \right) \right\}$. Since the error function does not admit a primitive, $\gamma(\cdot, \cdot, \cdot)$ has been approximated using the expression

$$\gamma(R, \bar{S}, t) \simeq \text{erf} \left(\sqrt{2} R \bar{S} \right) e^{-P_1(R)(t-\bar{S})} e^{-P_2(R)(t-\bar{S})^2}, \quad (\text{B.3})$$

where $P_1(\cdot)$ and $P_2(\cdot)$ are two polynomials in R and the term $\text{erf}(\cdot)$ is justified by the need of forcing the approximating expression to be equal to $\gamma(R, \bar{S}, t)$ for $t = \bar{S}$ and $t \rightarrow \infty$. By a least-squares based numerical approach $P_1(\cdot)$ and $P_2(\cdot)$ have been identified as follows:

$$P_1(R) = 0.77R, \quad P_2(R) = 0.38R^2 - 0.03R + 0.05. \quad (\text{B.4})$$

Then, by inserting (B.4) in (B.3) and the resulting expression in (B.2) and by carrying out the integration, (11) results. A similar approach has been followed to derive (12).

REFERENCES

- [1] ISO 10012-1:1992, Quality assurance requirements for measuring equipment – Part 1: Metrological confirmation system for measuring equipment.
- [2] ISO 10012-2:1997, Quality assurance requirements for measuring equipment – Part 2: Guidelines for control of measurement processes.
- [3] ENV 13005:1999, Guide to the Expression of Uncertainty in Measurement.
- [4] ISO/IEC 17025:1999, General requirements for the competence of testing and calibration laboratories.
- [5] D.C.Montgomery, *Introduction to Statistical Quality Control*, John Wiley & Sons, Inc., Third ed., 1997.
- [6] M.Abramovitz, I.A.Stegun, *Handbook of Mathematical Functions*, New York, 1970.
- [7] E.S.Keeping, *Introduction to Statistical Inference*, Dover Publications Inc., New York – USA, 1995.
- [8] W.Wong, “What TUR Do You Really Need? Putting Statistical Theory into Practice,” Proc. *Measurement Science Conference*, Anaheim, CA–USA, Jan. 28–29, 1999.
- [9] A.Dorchak, “Extending the Workload Coverage of a Calibrator Using Automated Techniques,” Proc. *Measurement Science Conference*, Pasadena, CA–USA, Jan. 26–27, 1997.
- [10] A.R.Eagle, “A Method for Handling Errors in Testing and Measuring,” *Industrial Quality Control*, pp.10–15, March 1954.
- [11] D.Deaver, “Guardbanding with Confidence,” Proc. *NCSL Workshop and Symposium*, pp. 383–394, 1994.
- [12] M.L.Fecteau, “Test Uncertainty Ratio and Intelligent Instrumentation: From 4:1 to SPC to IPC in the Army Measurement System,” Proc. *NCSL Workshop and Symposium*, pp. 19–33, 1997.